



40V N-Channel MOSFETs

General Description

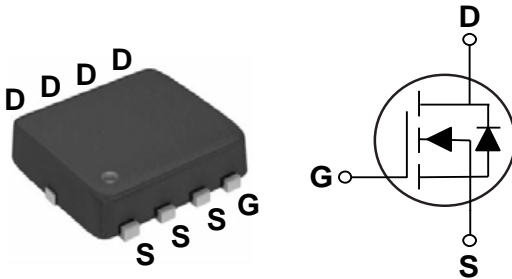
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BV_{DSS}	$R_{DS(ON)}$	I_D
40 V	13 m Ω	30 A

Features

- 40V, 30A, $R_{DS(ON)}=13m\Omega @V_{GS}=10V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

PPAK3X3 Pin Configuration



Applications

- Motor Drive
- Power Tools
- Quick Charger
- LED Lighting

Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	+20 / -12	V
I_D	Drain Current - Continuous ($T_C=25^\circ C$)	30	A
	Drain Current - Continuous ($T_C=100^\circ C$)	19	A
I_{DM}	Drain Current - Pulsed (NOTE 1)	120	A
EAS	Single Pulse Avalanche Energy (NOTE 2)	29	mJ
IAS	Single Pulse Avalanche Current (NOTE 2)	24	A
P_D	Power Dissipation ($T_C=25^\circ C$)	26	W
	Power Dissipation - Derate above 25 $^\circ C$	0.21	W/ $^\circ C$
T_J	Operating Junction Temperature Range	-50 to 150	$^\circ C$
T_{STG}	Storage Temperature Range	-50 to 150	$^\circ C$
Marking Code		ND013 / DC49B4	

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	---	62	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction to Case	---	4.8	$^\circ C/W$

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	40	---	---	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=40V, V_{GS}=0V, T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{DS}=32V, V_{GS}=0V, T_J=100^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=20V, V_{DS}=0V$	---	---	100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=4A$	---	11	13	m Ω
		$V_{GS}=4.5V, I_D=3A$	---	17	22	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	1.2	1.6	2.5	V
gfs	Forward Transconductance	$V_{DS}=10V, I_S=5A$	---	4	---	S

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
Q_g	Total Gate Charge (NOTE 3、4)	$V_{DS}=20V, V_{GS}=10V, I_D=15A$	---	6.9	10	nC
Q_{gs}	Gate-Source Charge (NOTE 3、4)		---	1.3	2	
Q_{gd}	Gate-Drain Charge (NOTE 3、4)		---	3	4.5	
$T_{d(on)}$	Turn-On Delay Time (NOTE 3、4)	$V_{DD}=20V, V_{GS}=10V, R_G=6\Omega, I_D=10A$	---	8	12	nS
T_r	Rise Time (NOTE 3、4)		---	12	18	
$T_{d(off)}$	Turn-Off Delay Time (NOTE 3、4)		---	25	38	
T_f	Fall Time (NOTE 3、4)		---	18	27	
C_{iss}	Input Capacitance	$V_{DS}=20V, V_{GS}=0V, F=1\text{MHz}$	---	495	740	pF
C_{oss}	Output Capacitance		---	310	460	
C_{rss}	Reverse Transfer Capacitance		---	13.5	20	
Rg	Gate resistance	$V_{GS}=0V, V_{DS}=0V, F=1\text{MHz}$	---	2	---	Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_S	Continuous Source Current	$V_G=V_D=0V, \text{Force Current}$	---	---	30	A
I_{SM}	Pulsed Source Current		---	---	60	A
V_{SD}	Diode Forward Voltage	$V_{GS}=0V, I_S=1A, T_J=25^\circ\text{C}$	---	---	1	V
trr	Reverse Recovery Time	$V_{GS}=10V, I_S=10A,$	---	15	---	nS
Qrr	Reverse Recovery Charge	$di/dt=100A/\mu s, T_J=25^\circ\text{C}$	---	11	---	nC

NOTES :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $V_{DD}=25V, V_{GS}=10V, L=0.1\text{mH}, I_{AS}=24A, R_G=25\Omega, \text{Starting } T_J=25^\circ\text{C}.$
3. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.



Characteristics Curves

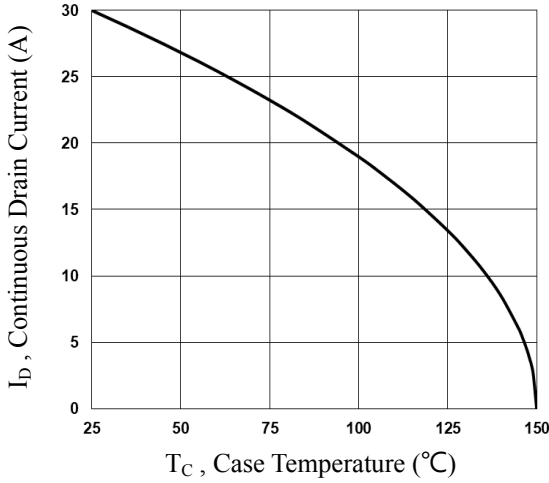


Fig.1 Continuous Drain Current vs. T_c

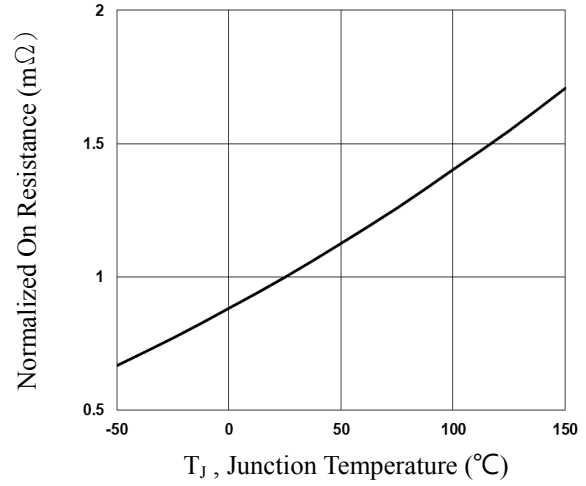


Fig.2 Normalized RDSON vs. T_j

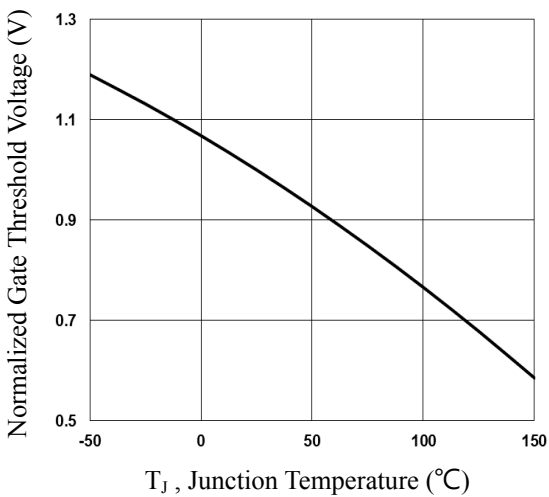


Fig.3 Normalized V_{th} vs. T_j

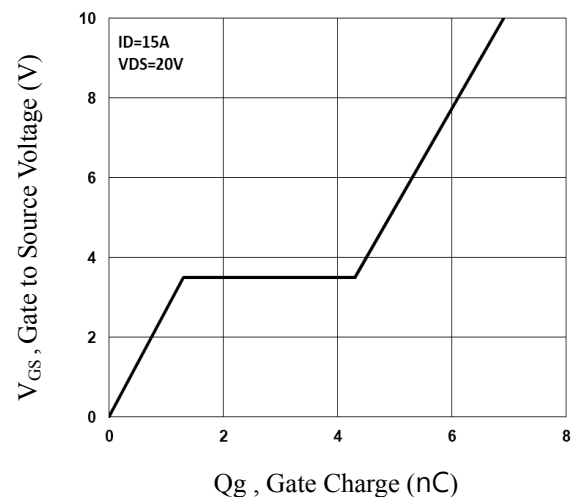


Fig.4 Gate Charge Waveform

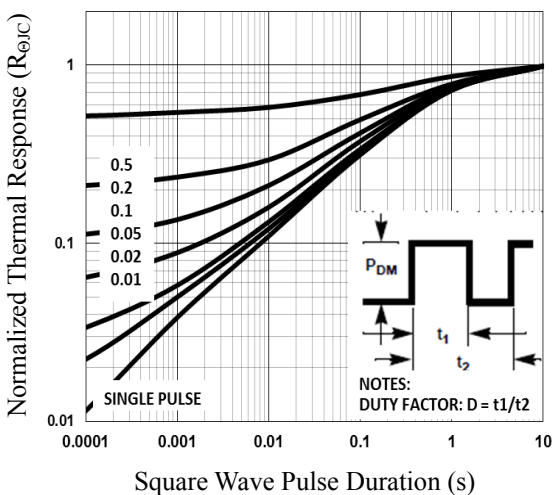


Fig.5 Normalized Transient Response

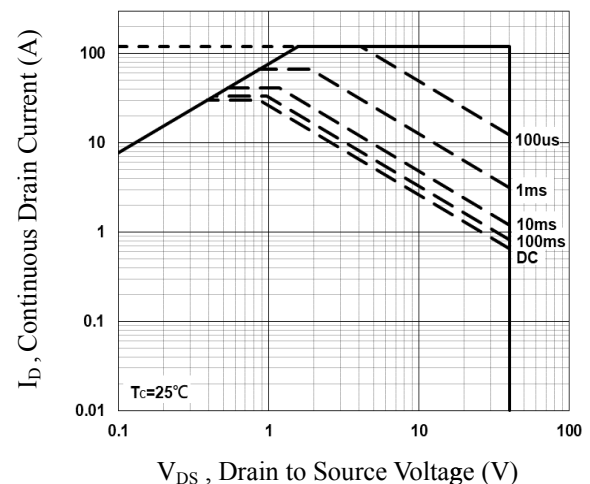


Fig.6 Maximum Safe Operation Area



Characteristics Curves

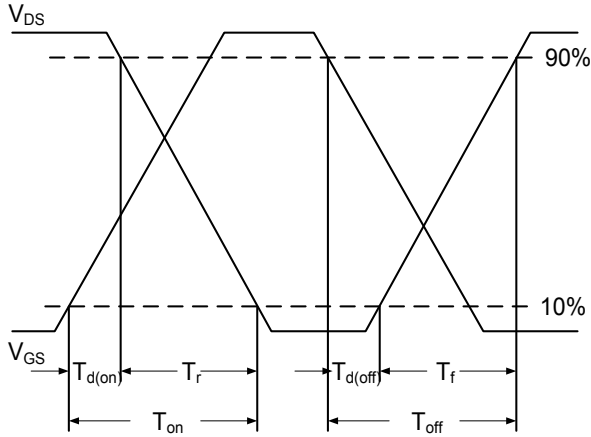


Fig.7 Switching Time Waveform

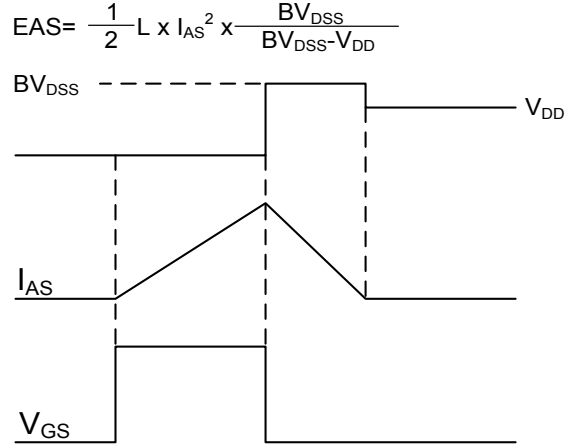
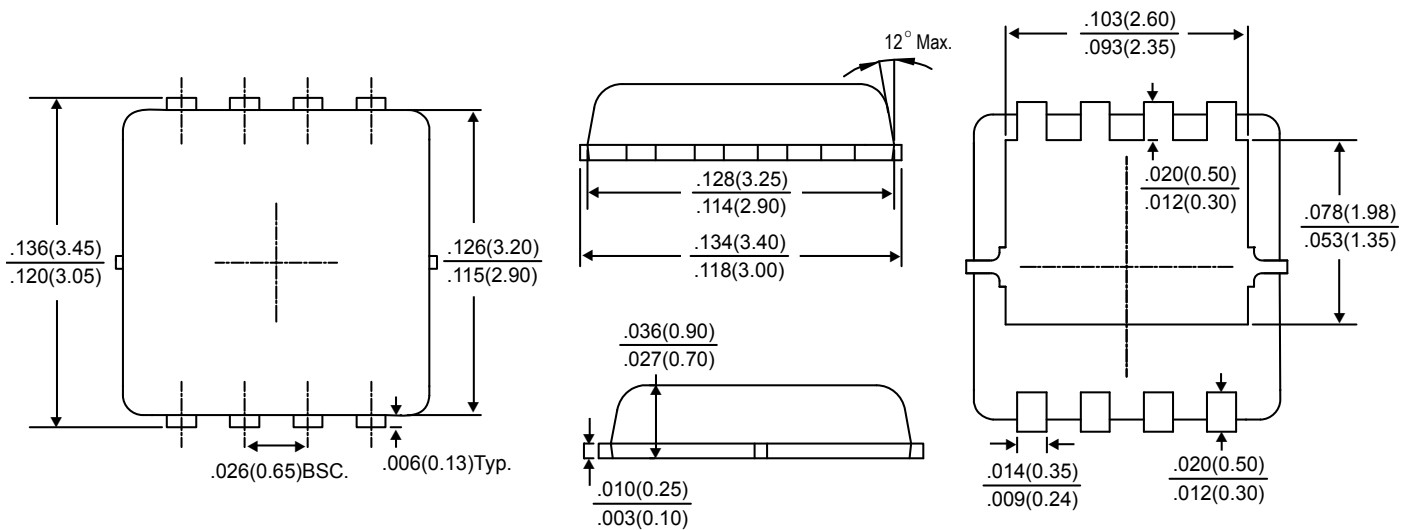


Fig.8 EAS Waveform

$$EAS = \frac{1}{2} L \times I_{AS}^2 \times \frac{BV_{DSS}}{BV_{DSS} - V_{DD}}$$

Package Outline Dimensions



PPAK3X3

Dimensions in inches and (millimeters)



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